

Fig. 1

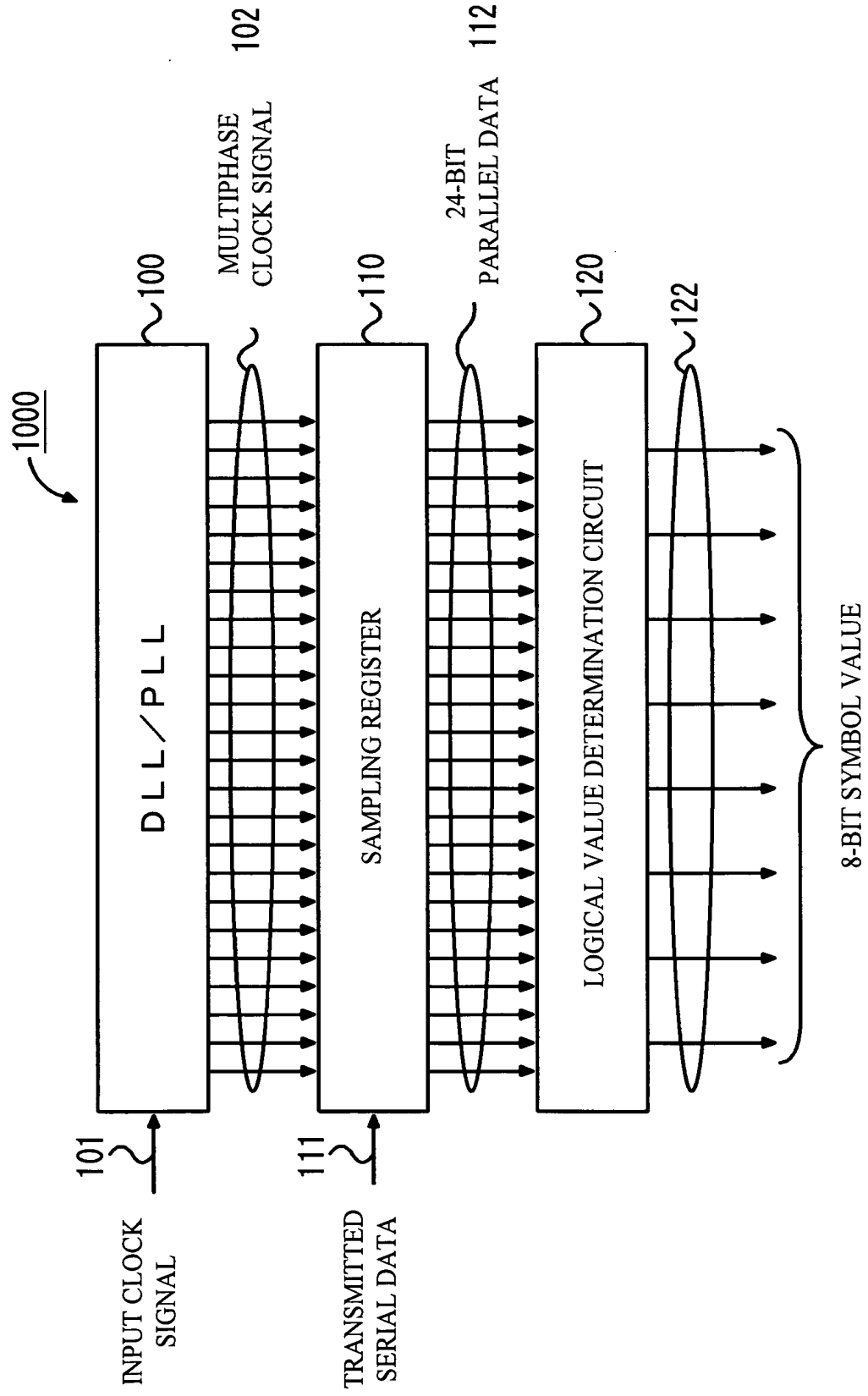


Fig. 2

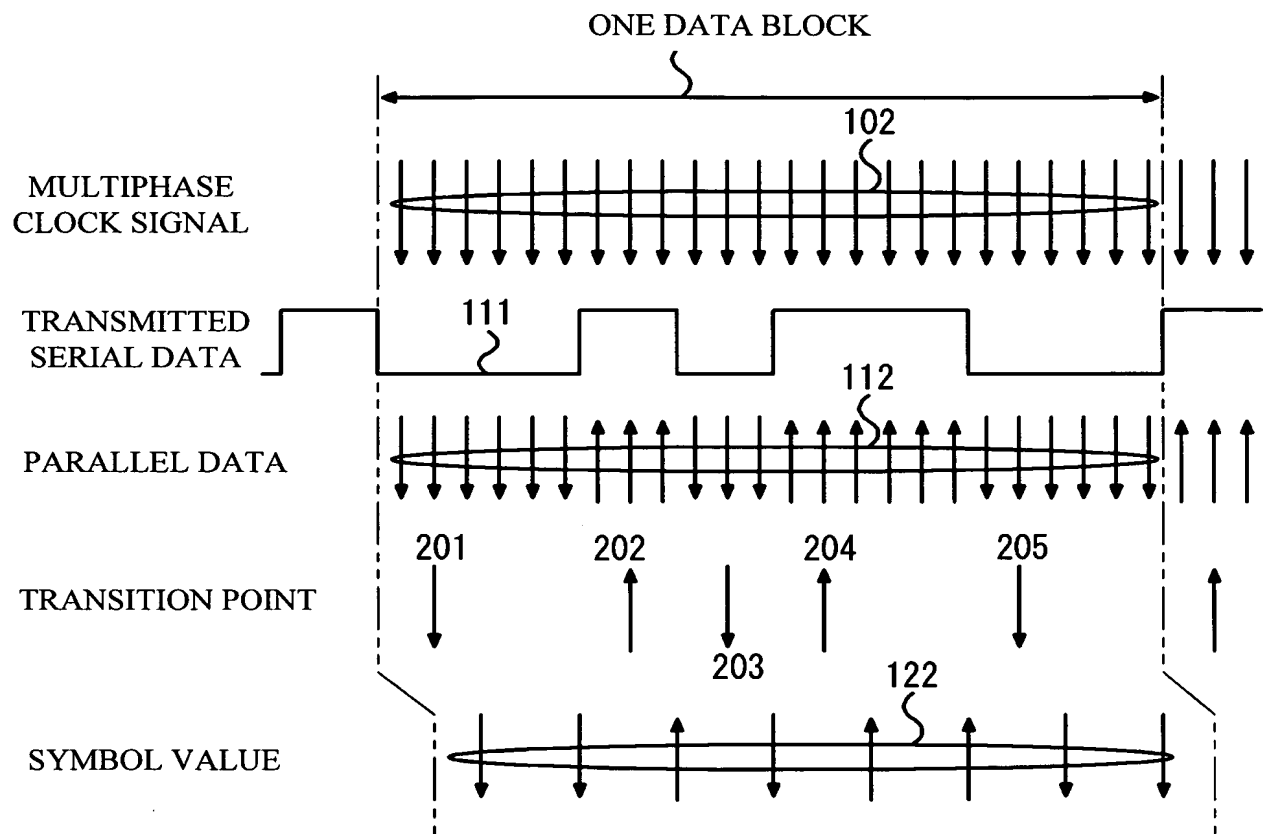


Fig. 3

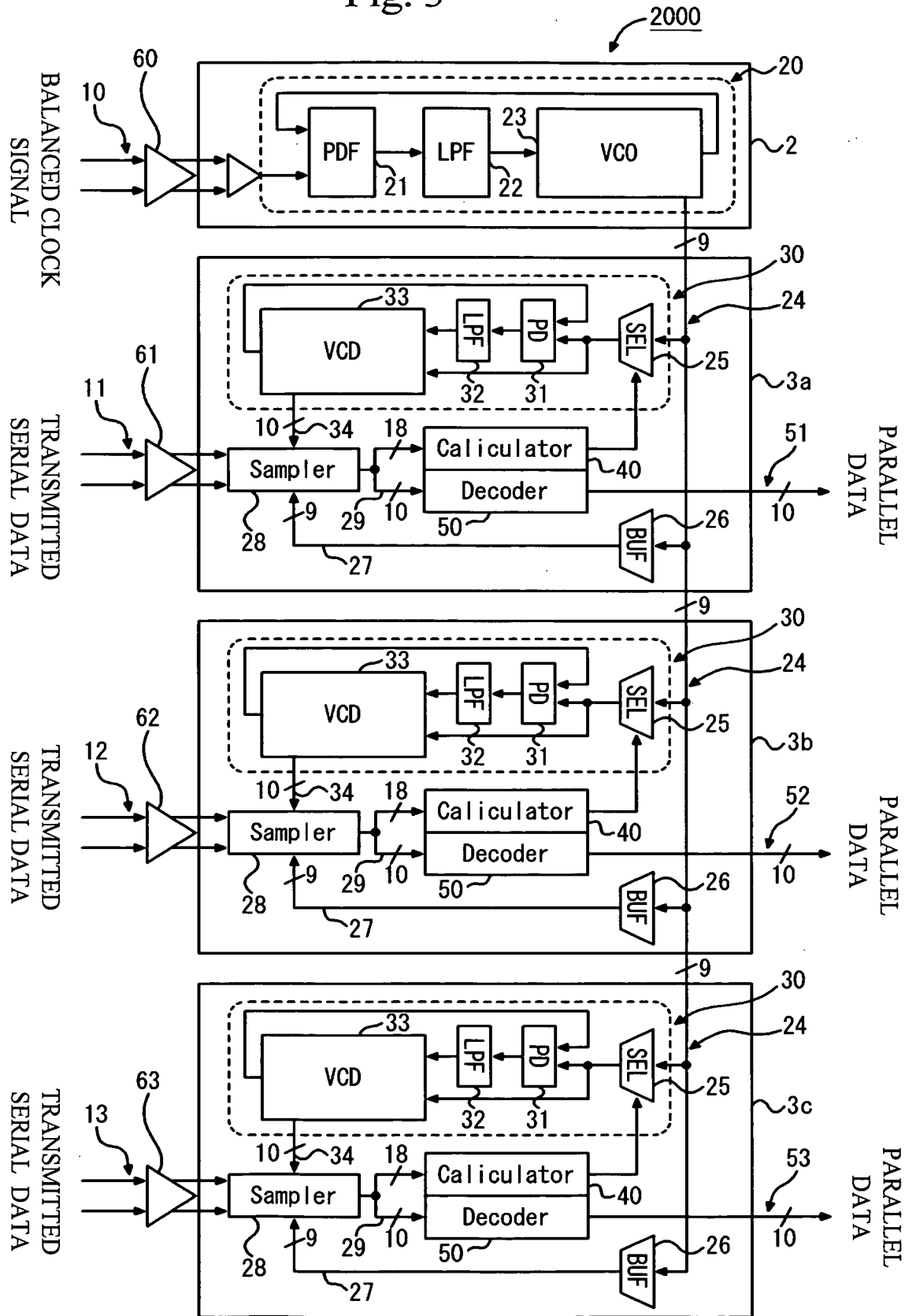


Fig. 4

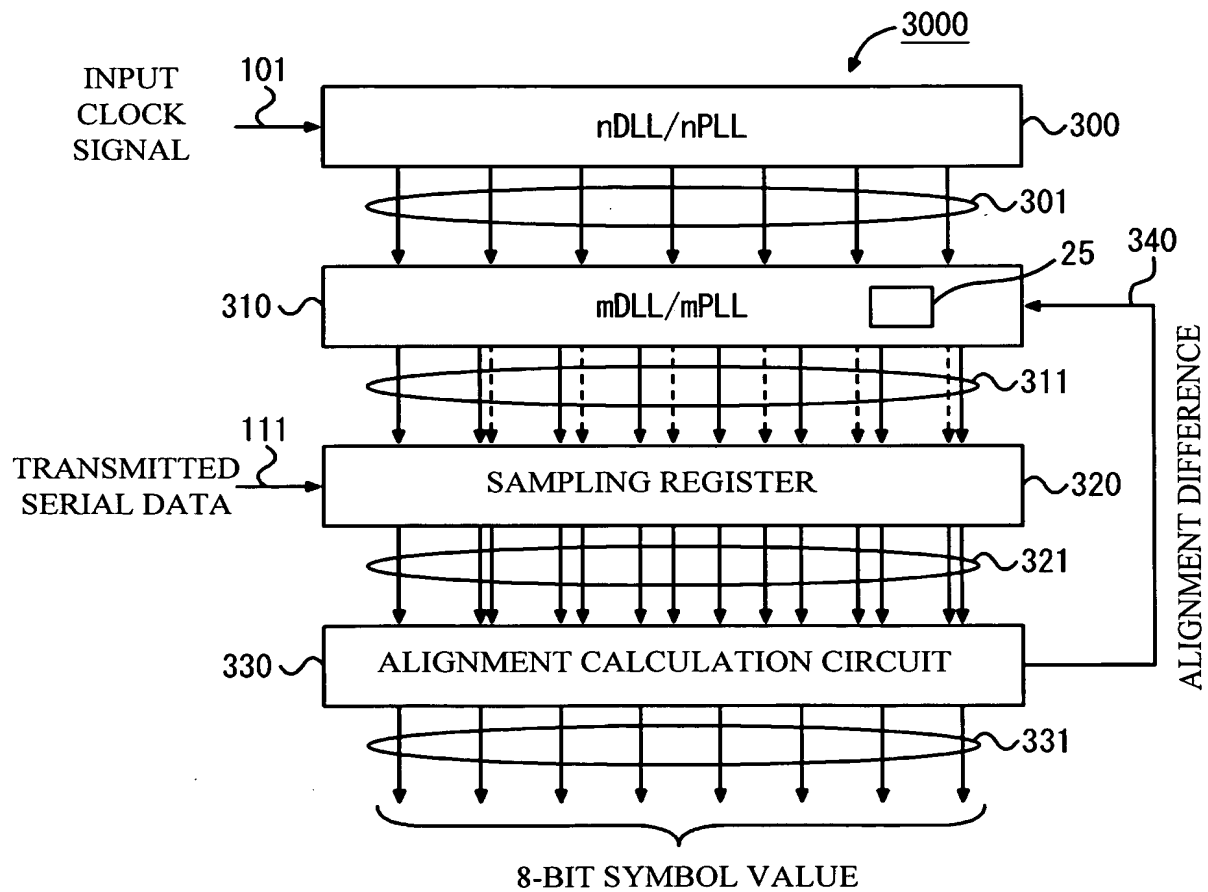


Fig. 5

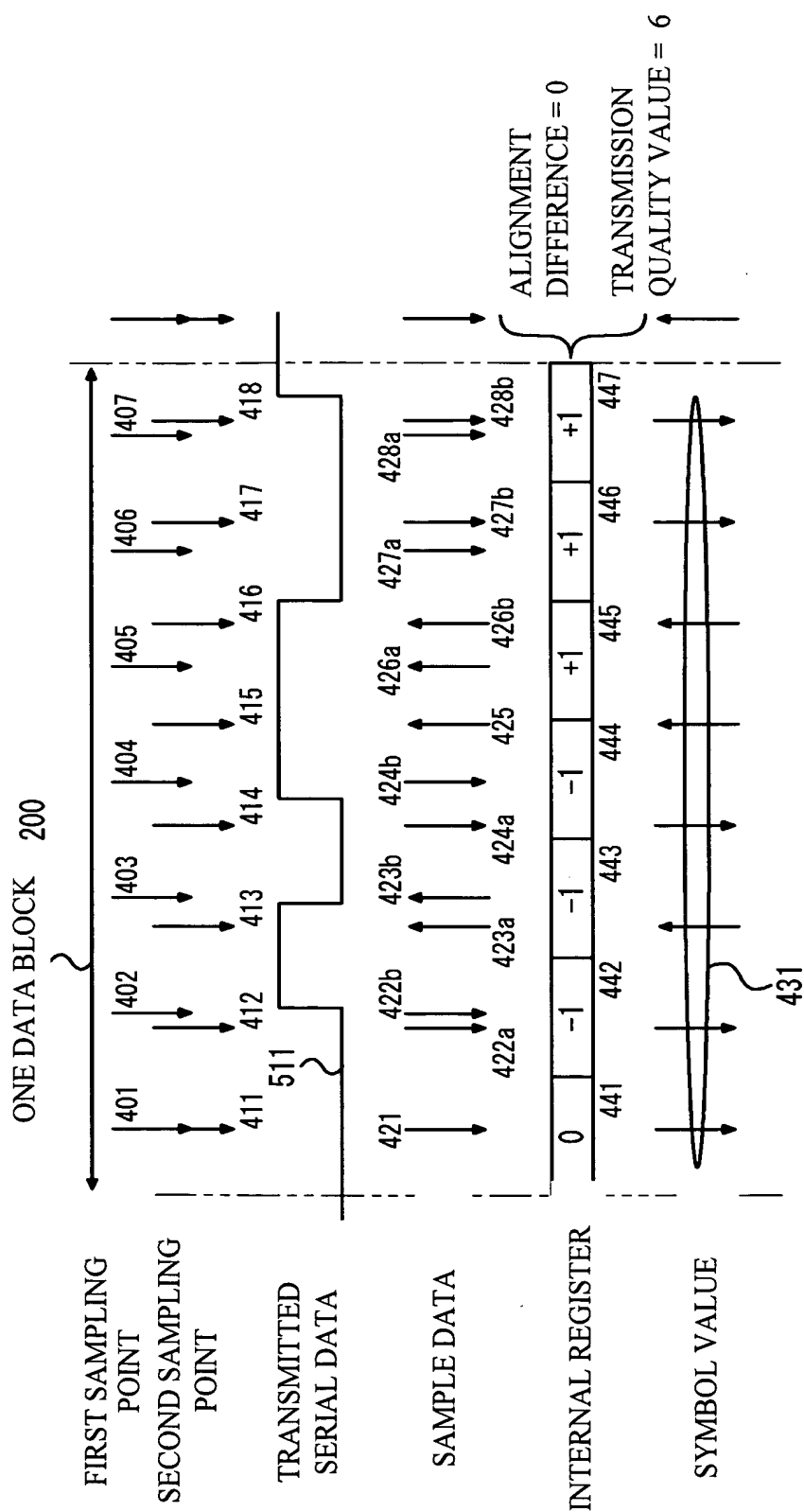


Fig. 6

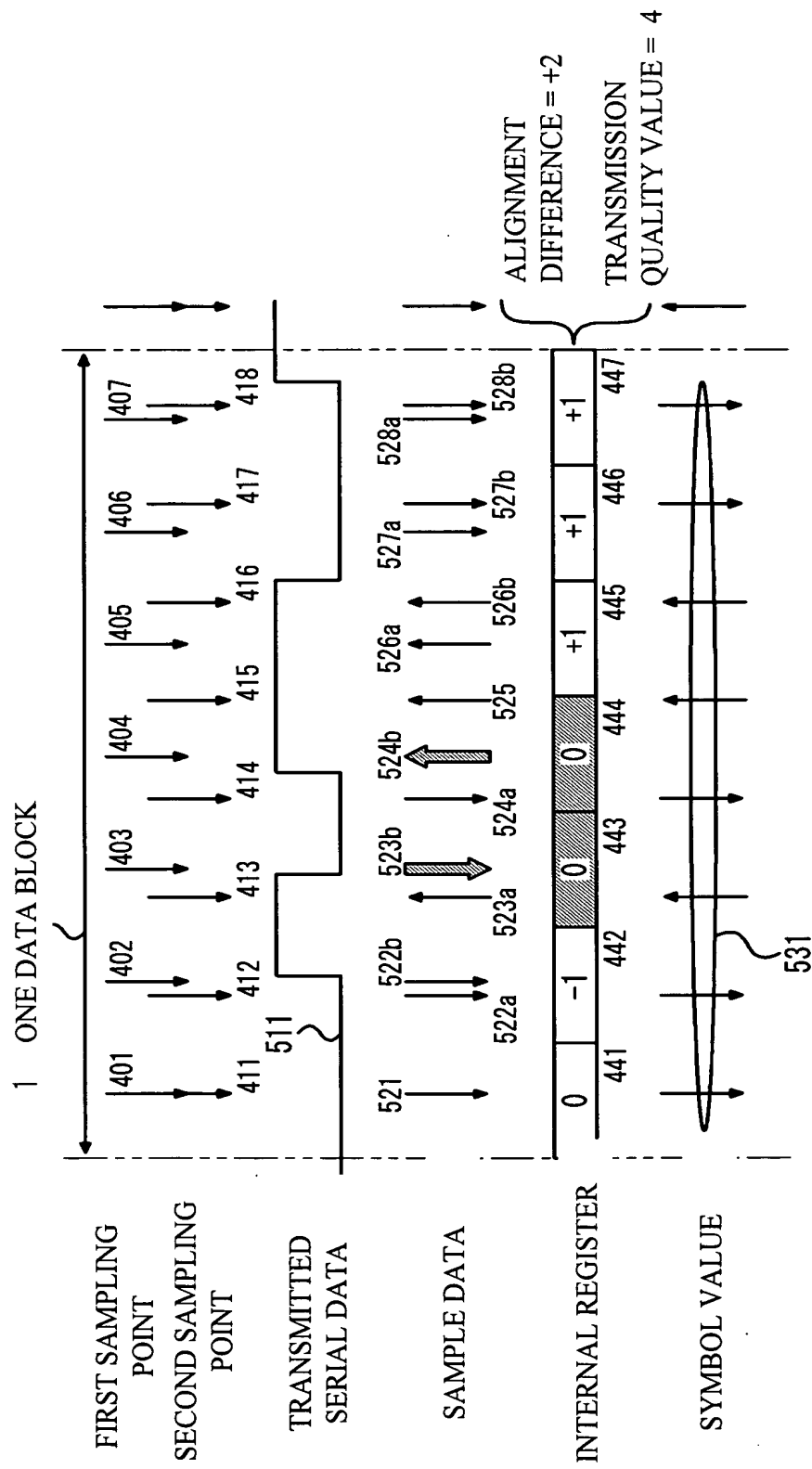


Fig. 7

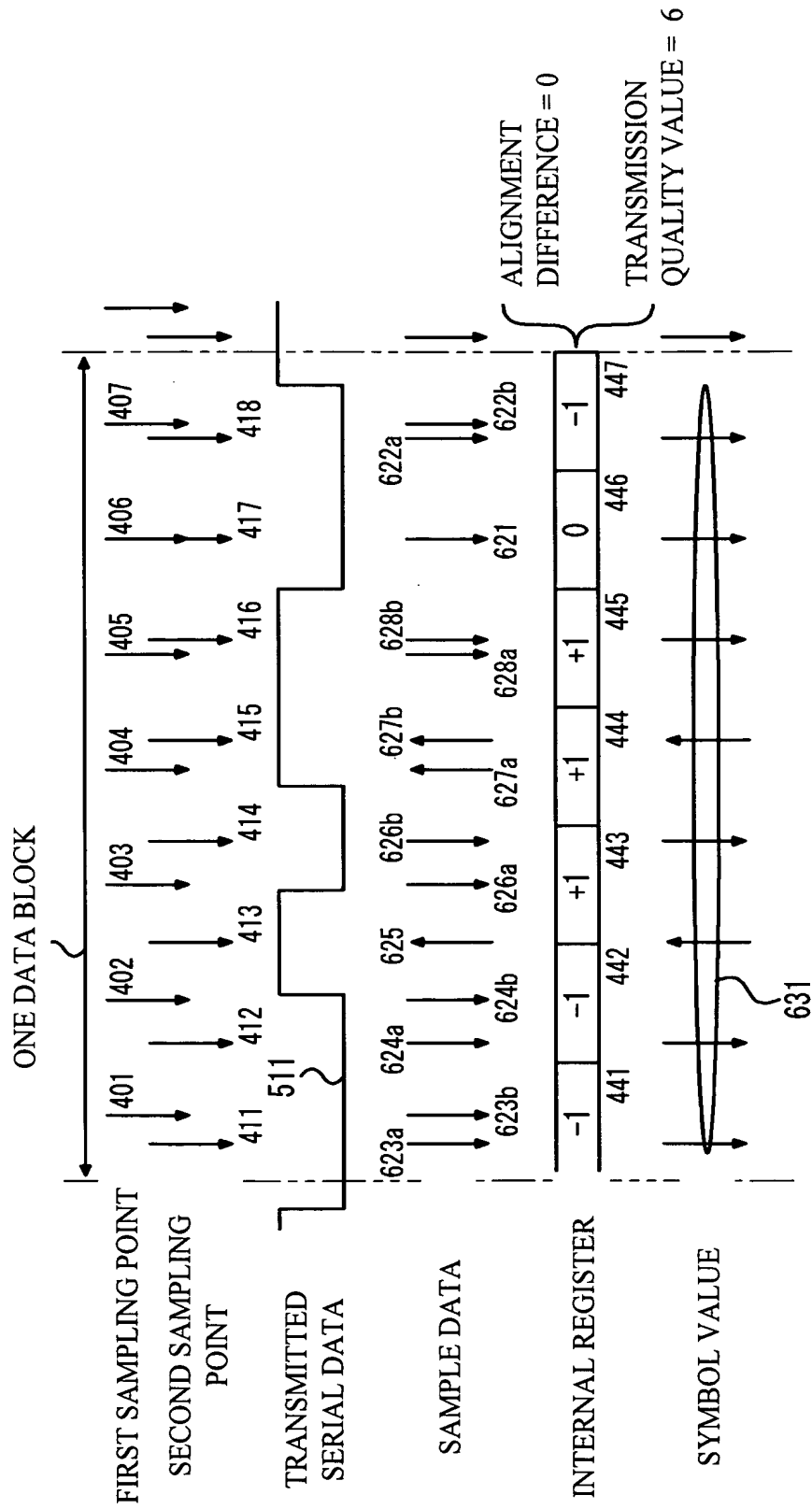


Fig. 8A

This Invention (M/N sampling method)

m	n	$m/n-1.0$	# of CLKs	skew shift(deg)
8	5	0.60	10	27.00
8	6	0.33	12	15.00
8	7	0.14	14	6.43

Fig. 8B

Prior Art (X sampling method)

m	X	——	# of CLKs	skew shift(deg)
8	3	——	24	15.00
8	4	——	32	11.25

Fig. 9

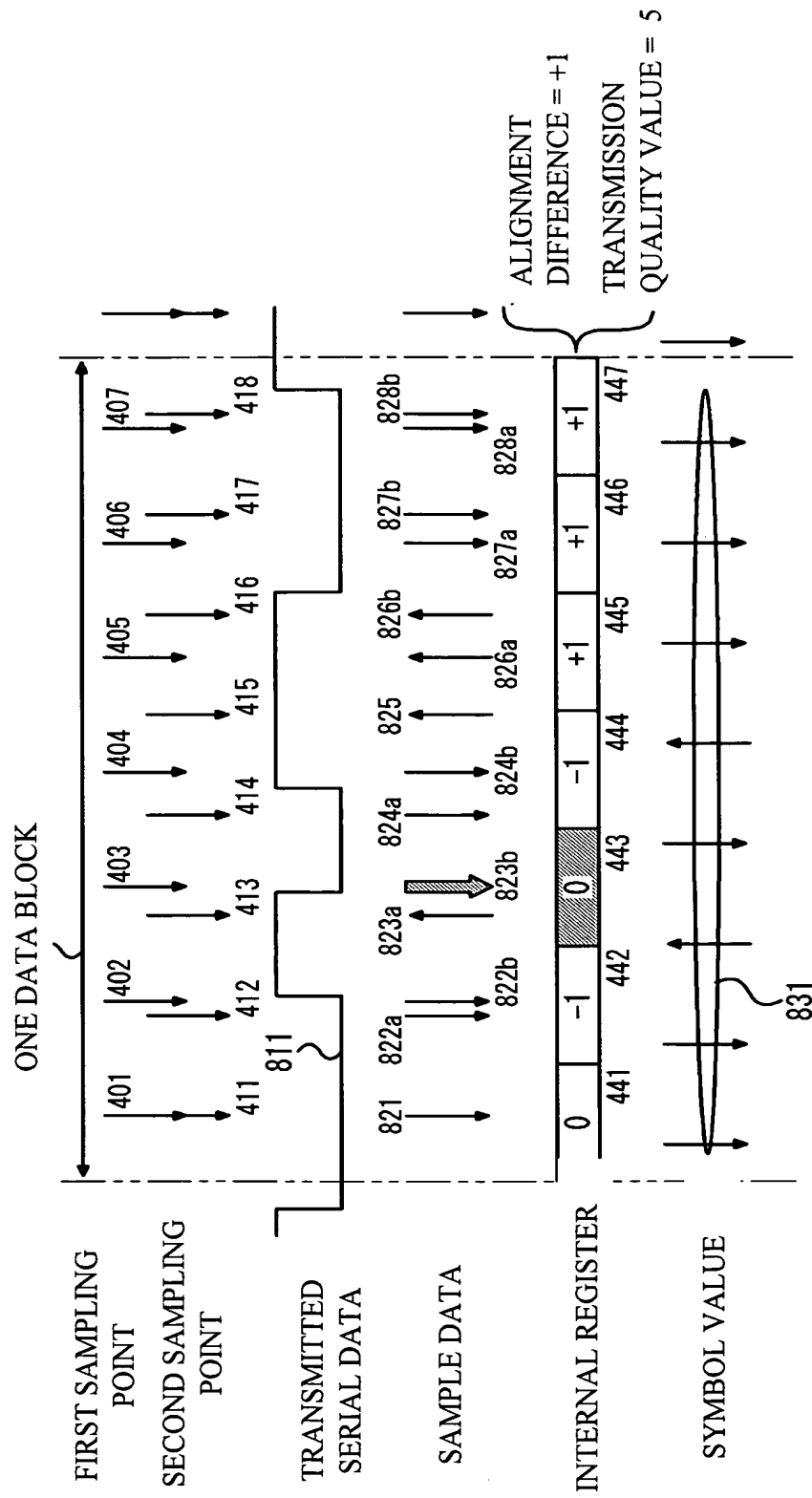


Fig. 10

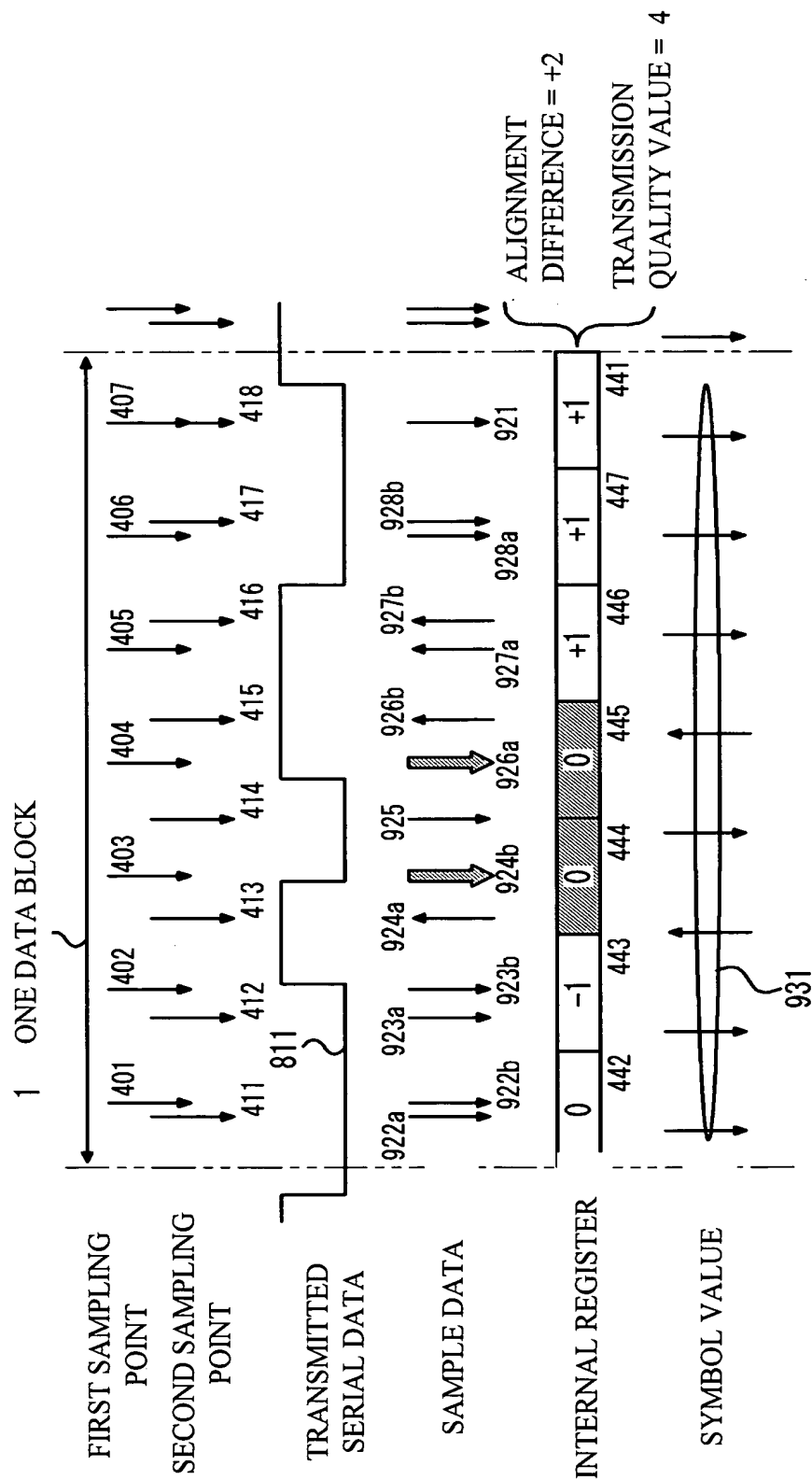


Fig. 11

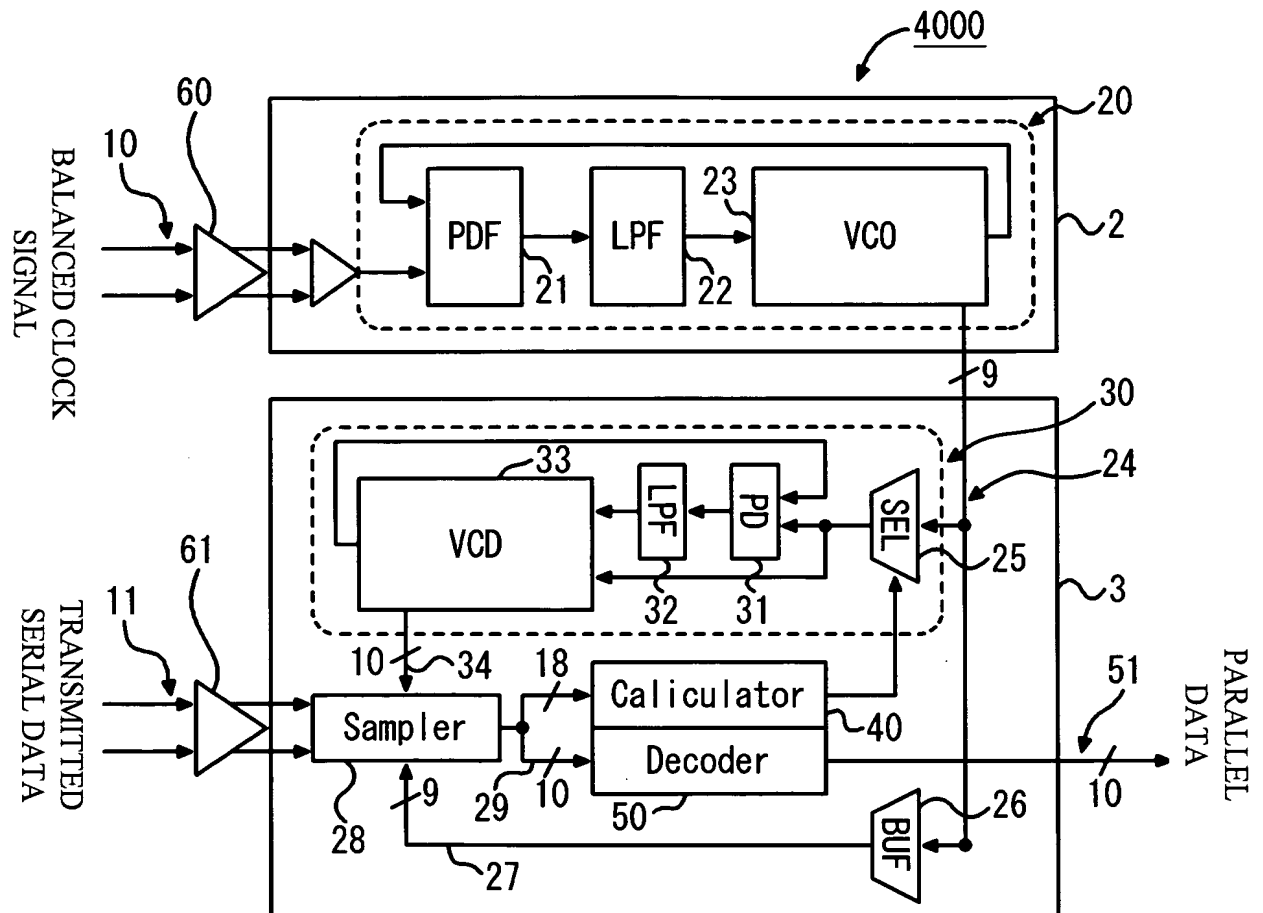


Fig. 12

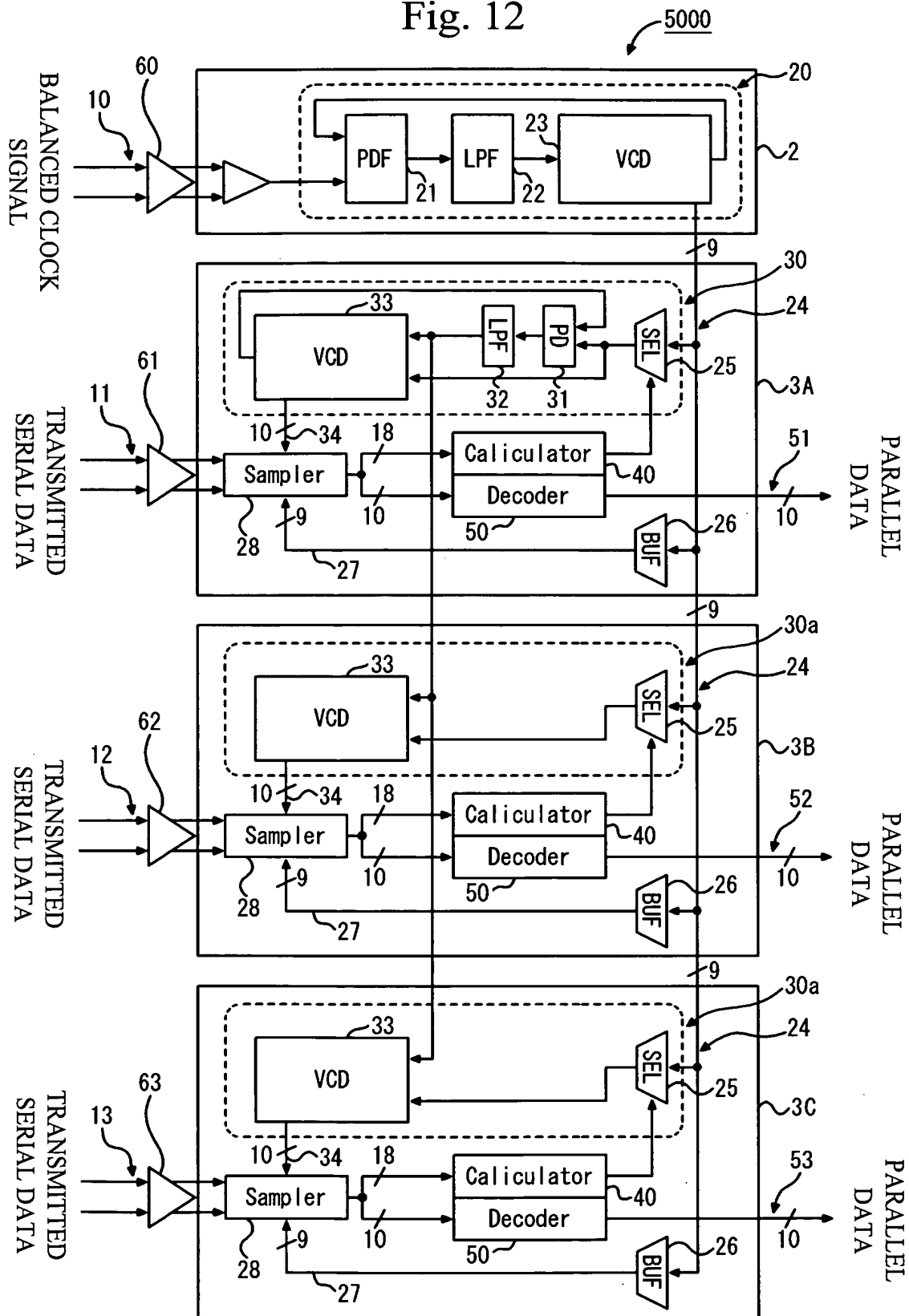


Fig. 13

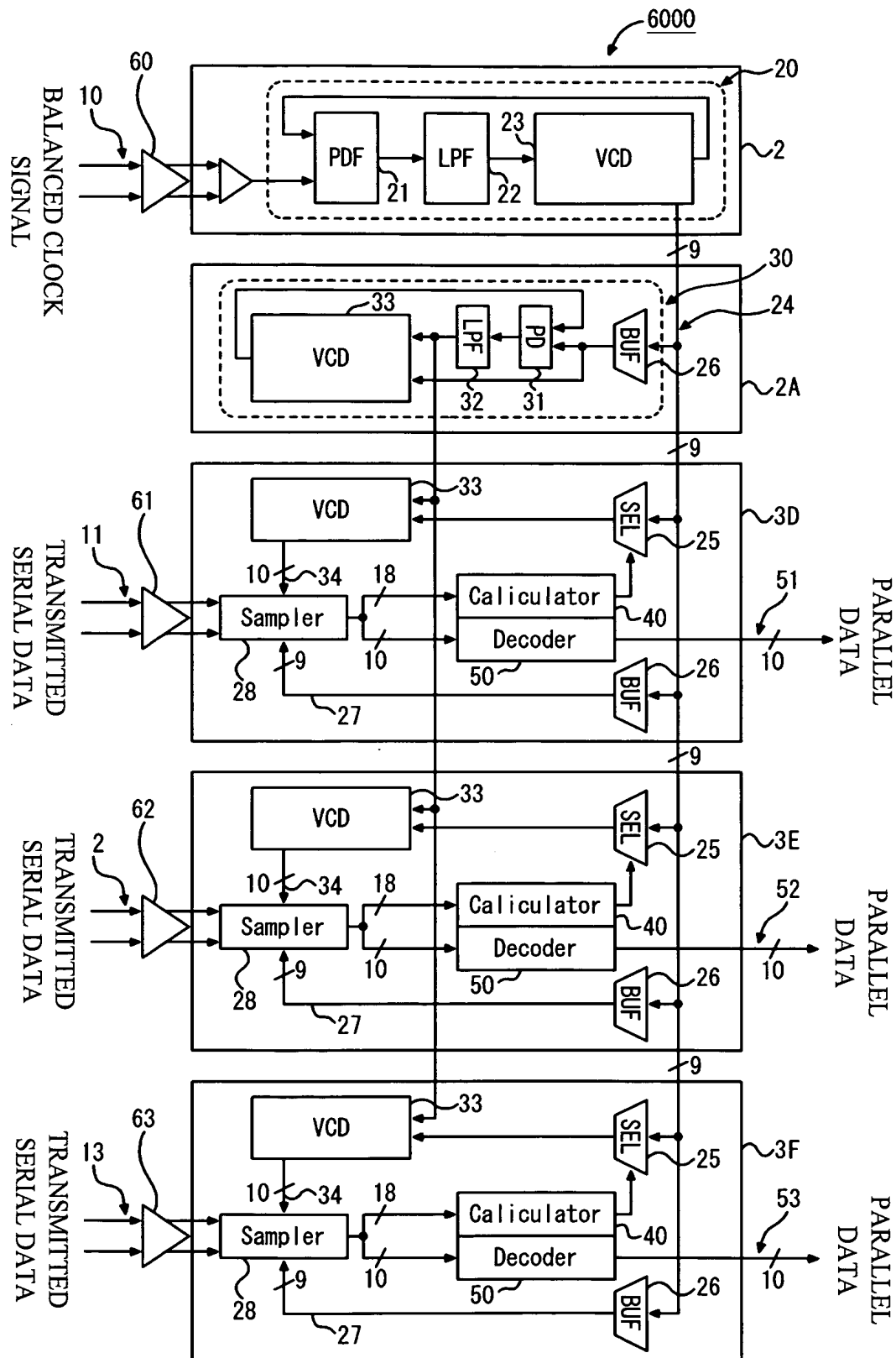


Fig. 14

